

Notice of References Cited	Application/Control No. 10/034,858	Applicant(s)/Patent Under Reexamination BARRITZ ET AL.	
	Examiner Neveen Abel-Jalil	Art Unit 2165	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,675,161	01-2004	Suchter, Sean A.	707/5
*	B	US-6,728,752	04-2004	Chen et al.	709/203
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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